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(71) Applicant: **AGENCY FOR SCIENCE, TECHNOLOGY AND RESEARCH** [SG/SG]; 1 Fusionopolis Way, #20-10, Connexis North Tower, Singapore 138632 (SG).

(72) Inventors: **CHENG, Jierong**; c/o PKM, Institute for Infocomm Research, 1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG). **SUN, Ying**; c/o PKM, Institute for Infocomm Research, 1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG). **XIONG, Wei**; c/o PKM, Institute for Infocomm Research,

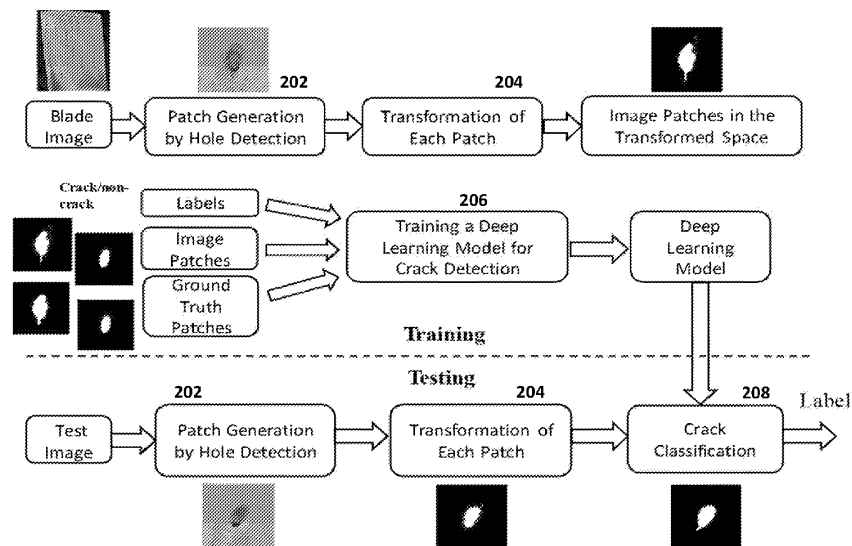
1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG). **CHEN, Wenyu**; c/o PKM, Institute for Infocomm Research, 1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG). **LI, Yusha**; c/o PKM, Institute for Infocomm Research, 1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG). **QUAN, Ying**; c/o PKM, Institute for Infocomm Research, 1 Fusionopolis Way, #21-01 Connexis (South Tower), Singapore 138632 (SG).

(74) Agent: **DAVIES COLLISON CAVE ASIA PTE. LTD.**; 10 Collyer Quay #07-01, Ocean Financial Centre, Singapore 049315 (SG).

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(54) Title: DEFECT DETECTION IN IMAGE SPACE

Figure 3



(57) Abstract: This invention relates to a method for training a neural network, comprising detecting a hole in each training image of a plurality of training images; transforming each training image into a transformed image, to suppress non-crack information in the training image; and training a neural network using the transformed images, to detect cracks in images (i.e. in objects in images).

[Continued on next page]

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